

Data sheet acquired from Harris Semiconductor SCHS108C – Revised October 2003

CMOS Quad 2-Line-to-1-Line Data Selector/Multi plexer

High-Voltage Types (20-Volt Rating)

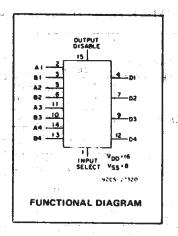
CD40257B is a Data Selector/Multiplexer featuring three-state outputs which can interface directly with and drive data lines of bus-oriented systems.

The CD40257B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

CD40257B Types

Features:

- 3-state outputs
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μA at 18 V over full package-temperature range;
 100 nA at 18 V and 25°C
- Noise margin (over full package temperature range):
 - 1 V at VDD = 5 V
 - 2 V at VDD = 10 V
 - 2.5 V at V_{DD} = 15 V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13A, "Standard Specifications for Description of 'B' Series CMOS Devices"



Applications:

- Digital Multiplexing
- Shift-right/shift-left registers
- True/complement selection

RECOMMENDED OPERATING CONDITION For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CUADACTEDIATIO	LIN	IITS :	UNITS		
CHARACTERISTIC	Min.	Max.			
Supply-Voltage Range (For TA=Full Package- Temperature Range)	3	18	٧		

MAXIMUM RATINGS, Absolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE, (VDD) Voltages referenced to VSS Terminal) Voltages referenced to VSS Terminal) O-0.5V to YDD +0.5V DC INPUT VOLTAGE RANGE, ALL INPUTS CINPUT CURRENT, ANY ONE INPUT ±10mA POWER DISSIPATION PER PACKAGE (PD): For TA = -55°C to +100°C FOR TA = +100°C to +125°C Derate Linearity at 12mW/°C to 200mW DEVICE DISSIPATION PER OUTPUT TRANSISTOR FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types) 100mW OPERATING-TEMPERATURE RANGE (Tatg) 55°C to +125°C STORAGE TEMPERATURE RANGE (Tatg) -85°C to +150°C LEAD TEMPERATURE (DURING SOLDERING): At distance 1/18 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max +265°C

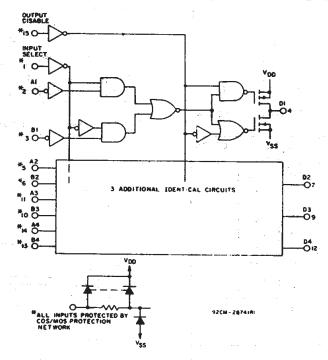
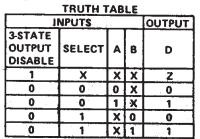


Fig. 1 - Logic diagram for CD40257B.



X = DON'T CARE LOGIC 1 = HIGH LOGIC 0 = LOW Z = HIGH IMPEDANCE

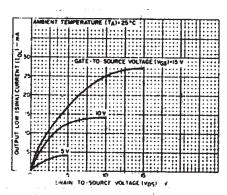


Fig.2 - Typical output low (sink) current characteristics.

STATIC ELECTRICAL CHARACTERISTICS

, 1	7.7										
CHARAC- TERISTIC		OITIC		LIMITS AT INDICATED TEMPERATURES (°C)							UNITS
TENISTIC	v _o	VIN	V _{DD}						+25		
	(V)	(V)	(V)	55	-40	+85	+125	Min.	Typ.	Max.	
Quiescent	_	0.5	5	1	1	30	30		0:02	1	
Device	_	0,10	10	2	2	60	60		0.02	2	μА
Current		0,15	15	4	4	120	120		0.02	4	μ
IDD Max.	-	0,20	20	20	20	600	600	, 	0.04	20	
Output Low											
(Sink)	0.4	0,5	5 :	0.64	0.61	0.42	0.36	0.51	1 1	_	
Current,	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	_	
IOL Min.	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	_	mA
Output High	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	_	
(Source)	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2		
Current,	9.5	0,10	10	-1.6	-1.5	-1.1	0.9	-1.3	-2.6	-	
I _{OH} Min.	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-	
Output Volt-											
age:	. —	0,5	5		0.0)5		_	0	0.05	
Low-Level.	-	0,10	10		0.0			_	0	0.05	
VOL Max.	_	0,15	15		0.0)5		_	0	0.05	v
Output Volt-		-	. :								ľ
age:	_	0,5	5	·	4.9	95		4.95	5	_	
High-Level,		0,10	10		9.9	95		9.95	10		
VOH Min.		0,15	15		14.	95		14.95	15	-	
Input Low	0.5,4.5	'-	5		1.	5		_		1.5	
Voltage,	1,9	-	10		3	3			-	3	
VIL Max.	1.5,13.5	_	15						_	4	v
Input High	0.5,4.5		5		3.	5		3.5			ľ
Voltage,	1,9	-	10		7						
VtH Min.	1.5,13.5	— ÷	15		1	1		11	-	-	
Input Current, IN Max.	_	0,18	18	±0.1	±0.1	±1	±1		±10-5	±0.1	μА
3-State Output Leakage Current IOUT Max.		0,18	18	±0.4	±0.4	±12	±12		±10 ⁻⁴	±0.4	μΑ

DYNAMIC ELECTRICAL CHARACTERISTICS at T $_A$ = 25°C; Input t_r , t_f = 20 ns, C $_L$ = 50 pF, R $_L$ = 200 $K\Omega$

CHARACTERISTIC	TEST CO	LIN	UNITS			
		V _{DD} (V)	Тур.	Max.		
Propagation Delay Time:		5	150	300		
Data Input to Output,		10	70	140	ns	
tPHL, tPLH		15	50	100		
Select to Output,		5	190	380		
tPHL, tPLH		10	85	170	ns	
PHL, PLH		15	65	130		
Output Disable to Output,		5	95	190		
		10	50	100	ns	
tPHL, tPLH		15	40	80		
TInt Time		5	100	200		
Transition Time,		10	50	100	ns	
тнь, ты		15	40	80		
Input Capacitance, CIN	Any Input	_	5	7.5	pF	

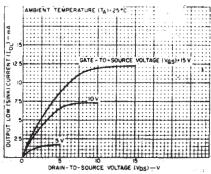


Fig.3 - Minimum output low (sink) current characteristics.

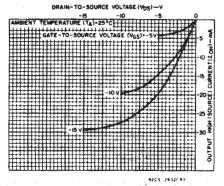


Fig.4 - Typical output high (source) current characteristics.

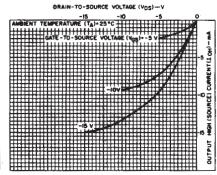


Fig.5 - Minimum output high (source) current characteristics.

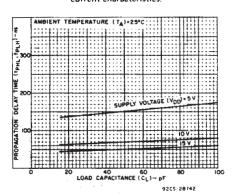


Fig.6 — Typical propagation delay time as a function of load capacitance (DATA INPUT to OUTPUT).

CD40257B Types

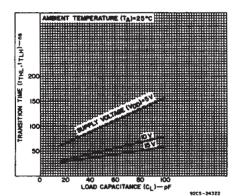


Fig.7 – Typical transition time as a function of load capacitance.

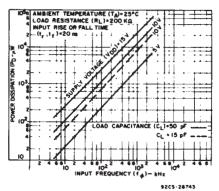


Fig.8 — Typical dynamic power dissipation as a function of input frequency (one INPUT to one OUTPUT).

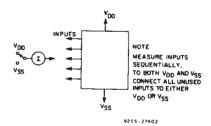


Fig.9 - Input current test circuit.

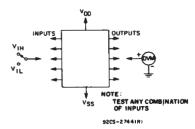


Fig. 10 - Input voltage test circuit.

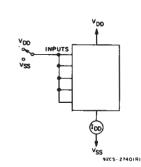
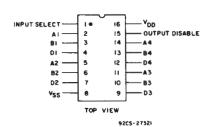
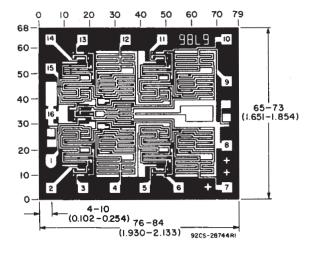


Fig.11 - Quiescent device current test circuit.



TERMINAL ASSIGNMENT

Dimensions and pad layout for CD402578H.



Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10°° inch).





10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD40257BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD40257BE	Samples
CD40257BEE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD40257BE	Samples
CD40257BF3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD40257BF3A	Samples
CD40257BM	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD40257BM	Samples
CD40257BMG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD40257BM	Samples
CD40257BMT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD40257BM	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

10-Jun-2014

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD40257B, CD40257B-MIL:

Catalog: CD40257B

Military: CD40257B-MIL

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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